

**Search Notes**

Application/Control No.

10/625,554

Examiner

Sun J. Lin

Applicant(s)/Patent under  
Reexamination

ITO ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	11	7/26/2005	JSL
716	8	7/26/2005	JSL
716	9	7/26/2005	JSL
716	10	7/26/2005	JSL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB]	7/26/2005	JSL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner